

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

TERANISHI ET AL.

Examiner

MICHAEL B. NELSON

Art Unit

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,440,572	08-2002	Yokoyama et al.	428/447
B	US-			
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D	US-			
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J	US-			
K	US-			
L	US-			
M	US-			

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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